Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	_
10/791,325	SUN ET AL.	
Examiner	Art Unit	_
Hung Vu	2811	

	SEARCHED					
Class	Subclass	Date	Examiner			
257	686,723, 777	oali7/05	<u>V</u>			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
See A	Hachment	00/17/05	V <u>n</u>		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
(EPC, JPO, DERWENT, US. PEPUB, USOCR, IBM. TDB) See Attachment	oglirlos	Vn		